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INFORMATION DISCLOSURE STATEMENT BY APPLICANT Form PTO/SB/08a

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Application Number	10/695,863					
Filing Date	October 30, 2003					
First Named Inventor	Hiroyuki NAGANO					
Art Unit	·					
Examiner Name						
Attorney Docket Number	024016-00072					

U.S. PATENT DOCUMENTS									
Examiner Initials*	Cite No.'	Document Number	Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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Examiner	/Frank Leiva/	Date	06/15/2007
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. *Unique citation designation number. *See attached Kinds of U.S. Patent Documents. *Enter Office that issued the document, by the two-letter code. *For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. *Kind of document by the appropriate symbots as indicated on the document under WIPO Standard ST. 16 if possible. *Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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